

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/710,456	<b>Applicant(s)/Patent under Reexamination</b> KEMP ET AL.
<b>Examiner</b> Huyen Le	<b>Art Unit</b> 3751	

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
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